



## Description

The IRLR7843TRPBF uses advanced trench technology to provide excellent  $R_{DS(ON)}$ , low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.



TO252-2L

## General Features

$V_{DS} = 30V$   $I_D = 120A$

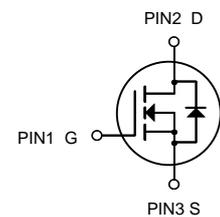
$R_{DS(ON)} < 3.8m\Omega @ V_{GS}=10V$

## Application

Battery protection

Load switch

Uninterruptible power supply



N-Channel MOSFET

## Package Marking and Ordering Information

| Product ID    | Pack     | Marking          | Qty(PCS) |
|---------------|----------|------------------|----------|
| IRLR7843TRPBF | TO252-2L | 120N03 XXXX YYYY | 2500     |

## Absolute Maximum Ratings ( $T_C=25^\circ C$ unless otherwise noted)

| Symbol                  | Parameter  | Rating     | Units        |
|-------------------------|--|------------|--------------|
| $V_{DS}$                | Drain-Source Voltage                             | 30         | V            |
| $V_{GS}$                | Gate-Source Voltage                              | $\pm 20$   | V            |
| $I_D @ T_C=25^\circ C$  | Continuous Drain Current, $V_{GS} @ 10V^1$       | 120        | A            |
| $I_D @ T_C=100^\circ C$ | Continuous Drain Current, $V_{GS} @ 10V^1$       | 75         | A            |
| $I_{DM}$                | Pulsed Drain Current <sup>2</sup>                | 384        | A            |
| EAS                     | Single Pulse Avalanche Energy <sup>3</sup>       | 196        | mJ           |
| $I_{AS}$                | Avalanche Current                                | 53.8       | A            |
| $P_D @ T_C=25^\circ C$  | Total Power Dissipation <sup>4</sup>             | 62.5       | W            |
| $T_{STG}$               | Storage Temperature Range                        | -55 to 150 | $^\circ C$   |
| $T_J$                   | Operating Junction Temperature Range             | -55 to 150 | $^\circ C$   |
| $R_{\theta JA}$         | Thermal Resistance Junction-Ambient <sup>1</sup> | 62         | $^\circ C/W$ |



**Electrical Characteristics (T<sub>J</sub>=25 °C, unless otherwise noted)**

| Symbol   | Parameter                        | Test Conditions   | Min. | Typ.     | Max.     | Unit |
|--|----------------------------------|---|------|----------|----------|------|
| <b>Static Characteristics</b>                  |                                  |   |      |          |          |      |
| BV <sub>DSS</sub>                              | Drain-Source Breakdown Voltage   | V <sub>GS</sub> =0V, I <sub>DS</sub> =250μA   | 30   | -        | -        | V    |
| I <sub>DSS</sub>                               | Zero Gate Voltage Drain Current  | V <sub>DS</sub> =24V, V <sub>GS</sub> =0V<br>T <sub>J</sub> =85°C   | -    | -        | 1<br>30  | μA   |
| V <sub>GS(th)</sub>                            | Gate Threshold Voltage           | V <sub>DS</sub> =V <sub>GS</sub> , I <sub>DS</sub> =250μA   | 1.4  | 1.7      | 2.5      | V    |
| I <sub>GSS</sub>                               | Gate Leakage Current             | V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V  | -    | -        | ±100     | nA   |
| R <sub>DS(ON)</sub> <sup>d</sup>               | Drain-Source On-state Resistance | V <sub>GS</sub> =10V, I <sub>DS</sub> =20A<br>T <sub>J</sub> =125°C   | -    | 3<br>4.4 | 3.8<br>- | mΩ   |
|  |                                  | V <sub>GS</sub> =4.5V, I <sub>DS</sub> =15A   | -    | 4.0      | 5.5      |      |
| Gfs  | Forward Transconductance         | V <sub>DS</sub> =5V, I <sub>DS</sub> =10A   | -    | 24.6     | -        | S    |
| <b>Diode Characteristics</b>                   |                                  |   |      |          |          |      |
| V <sub>SD</sub> <sup>d</sup>                   | Diode Forward Voltage            | I <sub>SD</sub> =20A, V <sub>GS</sub> =0V   | -    | 0.8      | 1.1      | V    |
| t <sub>rr</sub>                                | Reverse Recovery Time            | I <sub>DS</sub> =20A, di <sub>SD</sub> /dt=100A/μs  | -    | 35.6     | -        | ns   |
| t <sub>a</sub>                                 | Charge Time                      |   | -    | 19.3     | -        |      |
| t <sub>b</sub>                                 | Discharge Time                   |   | -    | 16.3     | -        |      |
| Q <sub>rr</sub>                                | Reverse Recovery Charge          |   | -    | 26       | -        |      |
| <b>Dynamic Characteristics<sup>e</sup></b>     |                                  |   |      |          |          |      |
| R <sub>G</sub>                                 | Gate Resistance                  | V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, F=1MHz  | -    | 1        | 2        | Ω    |
| C <sub>iss</sub>                               | Input Capacitance                | V <sub>GS</sub> =0V,<br>V <sub>DS</sub> =15V,<br>Frequency=1.0MHz   | -    | 2485     | 2971     | pF   |
| C <sub>oss</sub>                               | Output Capacitance               |   | -    | 850      | -        |      |
| C <sub>riss</sub>                              | Reverse Transfer Capacitance     |   | -    | 85       | -        |      |
| t <sub>d(ON)</sub>                             | Turn-on Delay Time               | V <sub>DD</sub> =15V, R <sub>L</sub> =15Ω,<br>I <sub>DS</sub> =1A, V <sub>GEN</sub> =10V,<br>R <sub>G</sub> =6Ω | -    | 12.4     | 23       | ns   |
| t <sub>r</sub>                                 | Turn-on Rise Time                |   | -    | 9.5      | 18       |      |
| t <sub>d(OFF)</sub>                            | Turn-off Delay Time              |   | -    | 27.2     | 49       |      |
| t <sub>f</sub>                                 | Turn-off Fall Time               |   | -    | 35.2     | 64       |      |
| <b>Gate Charge Characteristics<sup>e</sup></b> |                                  |   |      |          |          |      |
| Q <sub>g</sub>                                 | Total Gate Charge                | V <sub>DS</sub> =15V, V <sub>GS</sub> =10V,<br>I <sub>DS</sub> =20A   | -    | 20.6     | 28.8     | nC   |
| Q <sub>g</sub>                                 | Total Gate Charge                | V <sub>DS</sub> =15V, V <sub>GS</sub> =4.5V,<br>I <sub>DS</sub> =20A  | -    | 9.8      | -        |      |
| Q <sub>gth</sub>                               | Threshold Gate Charge            |   | -    | 1.8      | -        |      |
| Q <sub>gs</sub>                                | Gate-Source Charge               |   | -    | 3.8      | -        |      |
| Q <sub>gd</sub>                                | Gate-Drain Charge                |   | -    | 3.7      | -        |      |

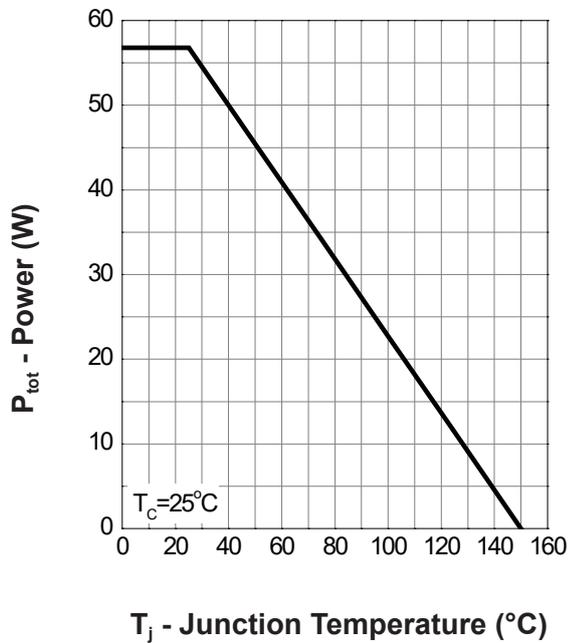
Note d : Pulse test ; pulse width≤300μs, duty cycle≤2%.

Note e : Guaranteed by design, not subject to production testing.

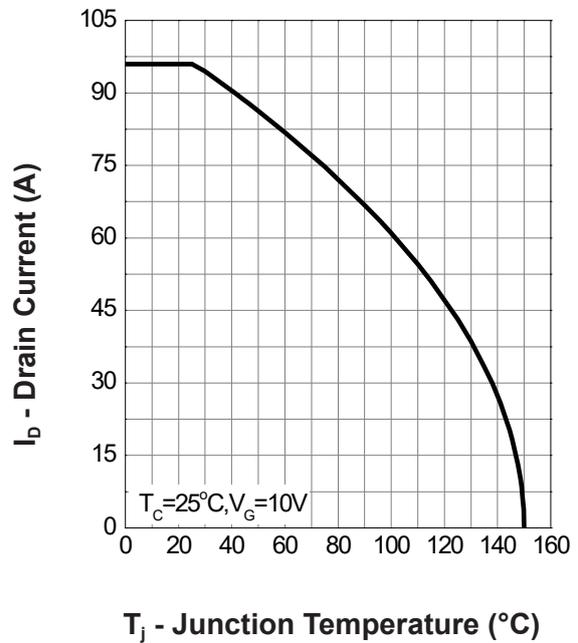


## Typical Operating Characteristics

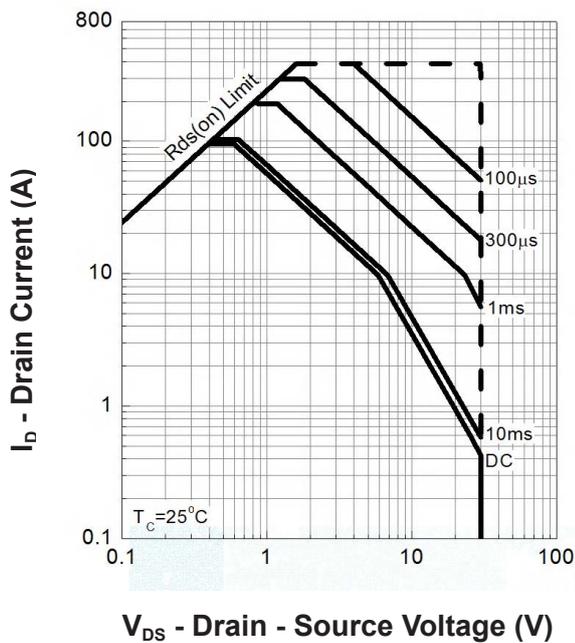
### Power Dissipation



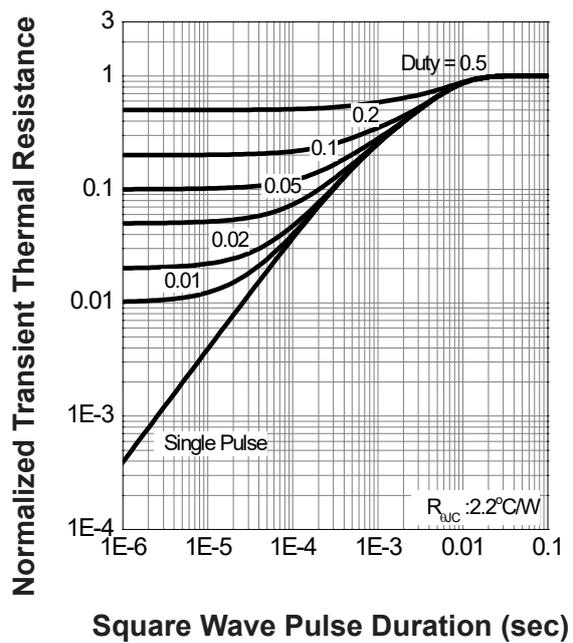
### Drain Current



### Safe Operation Area



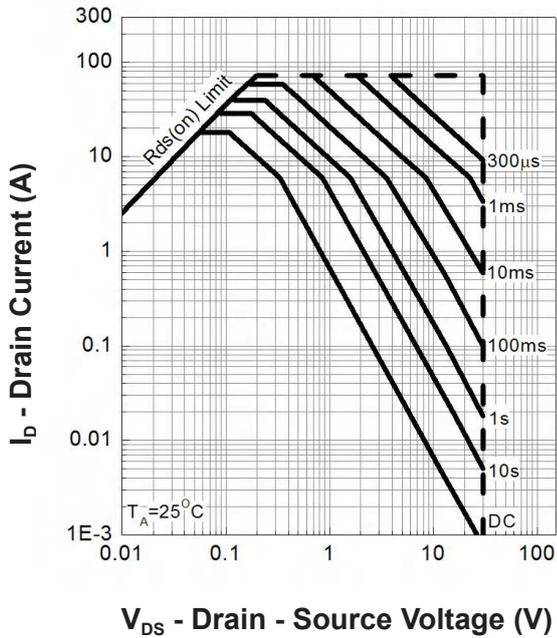
### Thermal Transient Impedance



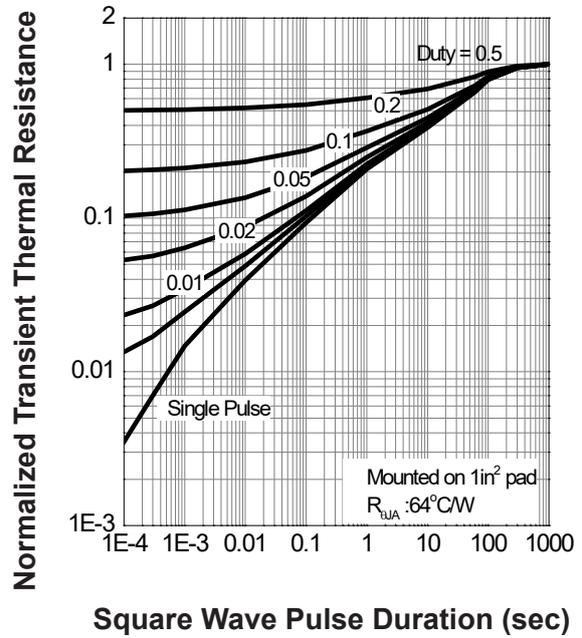


### Typical Operating Characteristics(Cont.)

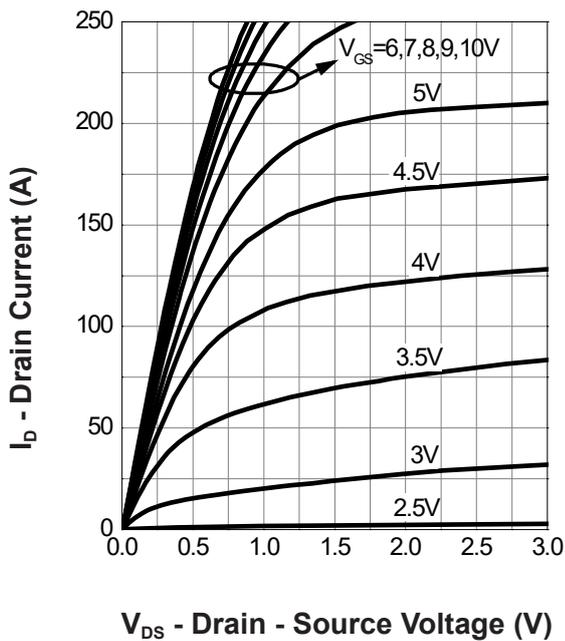
#### Safe Operation Area



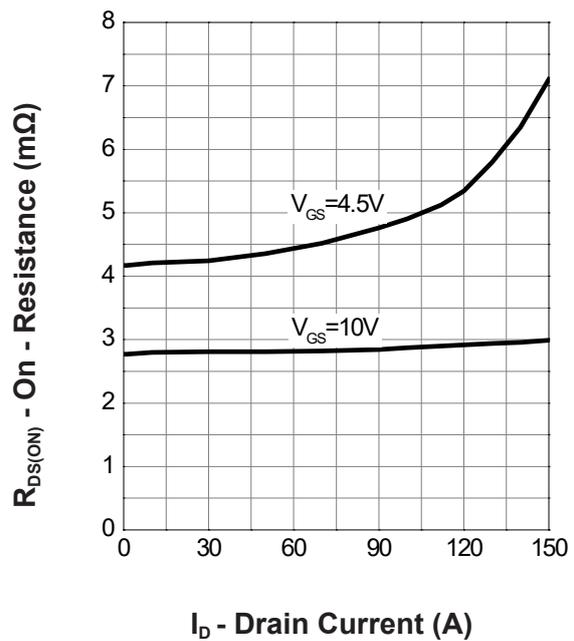
#### Thermal Transient Impedance



#### Output Characteristics



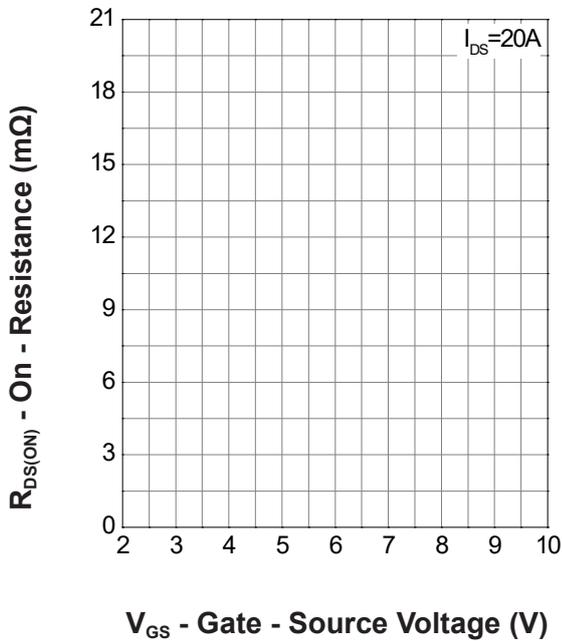
#### Drain-Source On Resistance



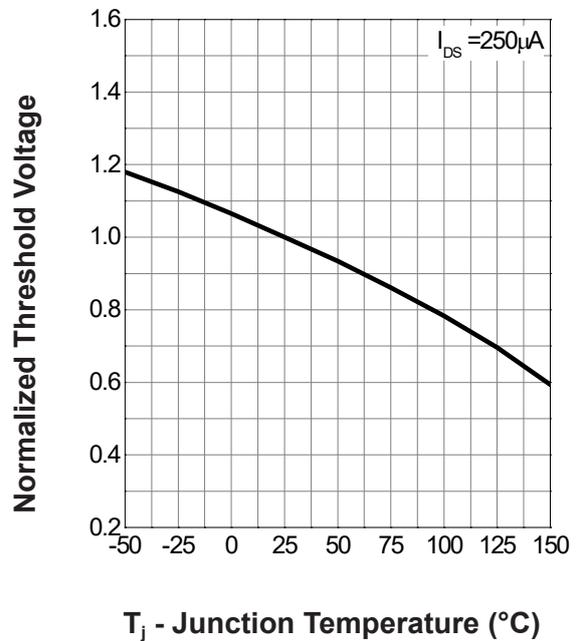


### Typical Operating Characteristics(Cont.)

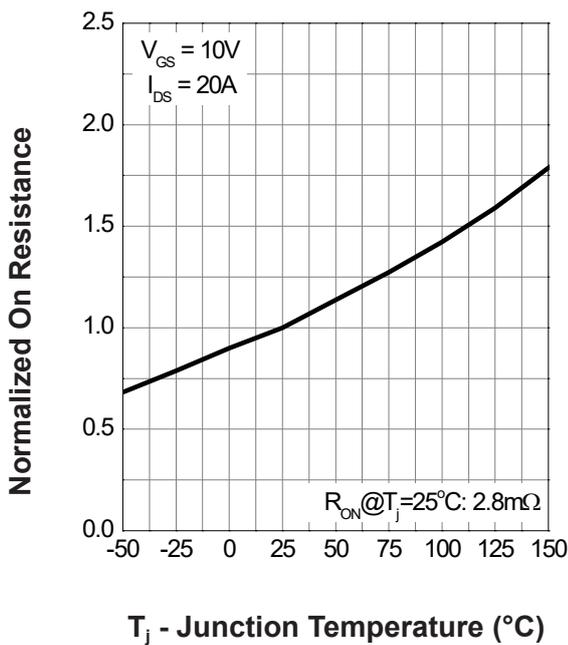
#### Gate-Source On Resistance



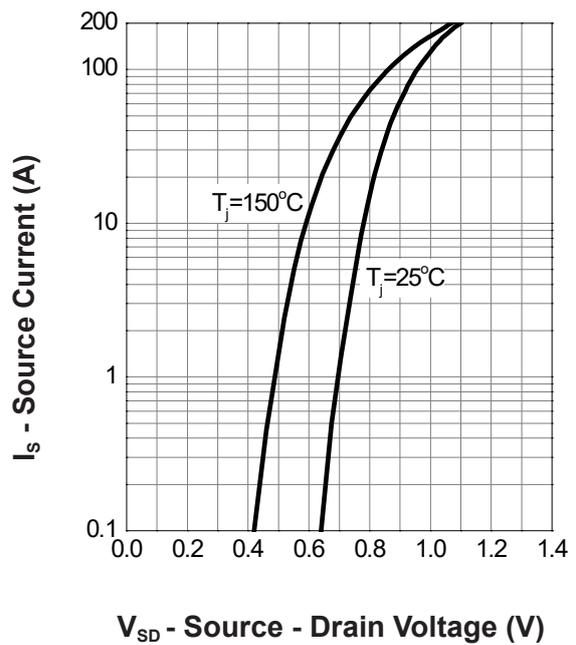
#### Gate Threshold Voltage



#### Drain-Source On Resistance



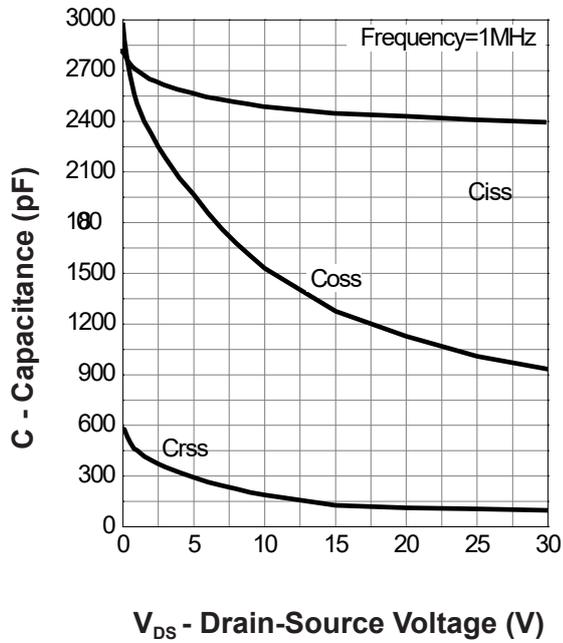
#### Source-Drain Diode Forward



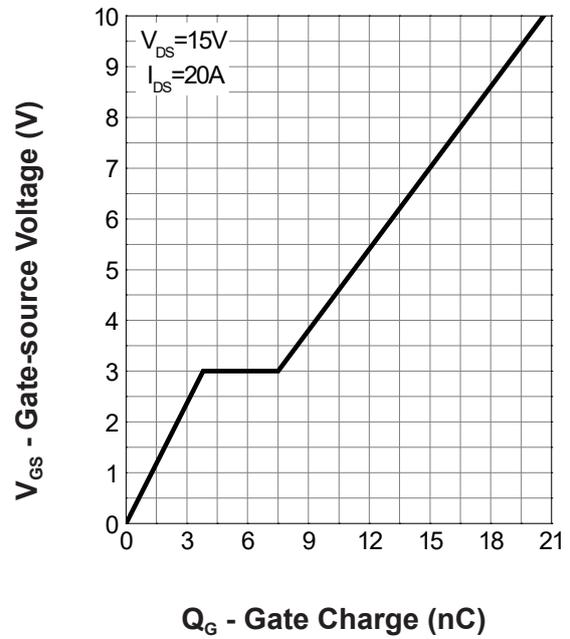


### Typical Operating Characteristics(Cont.)

Capacitance



Gate Charge







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